


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566705	<b>Applicant(s)/Patent Under Reexamination</b>  ICHIKAWA ET AL.
	<b>Examiner</b>  Eunhee Kim	<b>Art Unit</b>  2123

SEARCHED			
Class	Subclass	Date	Examiner
703	22	4/11/2008	Eunhee Kim
Updated	Above	12/5/2008	Eunhee Kim
703	7	12/5/2008	Eunhee Kim

SEARCH NOTES		
Search Notes	Date	Examiner
East Text search (See attached)	4/11/2008	Eunhee Kim
East Test search (See attached)	12/5/2008	Eunhee Kim

INTERFERENCE SEARCH			
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